Application/Control No. Applicant(s)/Patent Under Reexamination 10/521,117 CHOWDHRY ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 William K. Cheung 1713 **U.S. PATENT DOCUMENTS Document Number** Date Classification Country Code-Number-Kind Code Name MM-YYYY US-Α US-В US-С US-D Ε US-US-F US-G US-Н US-US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Classification Name Country Code-Number-Kind Code MM-YYYY WO 01/44325 A1 06-2001 World Kristen et al. Ν 0 Ρ Q R s Т NON-PATENT DOCUMENTS

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